

### Features

- $R_{DS(ON)} < 0.9\Omega$  @  $V_{GS} = 10V$
- Fast switching capability
- Low gate charge
- Lead free in compliance with EU RoHS directive.
- Green molding compound

### PRODUCT SUMMARY

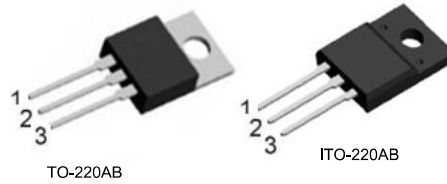
$V_{DS}$ (V)	$R_{DS(on)}$ ( $\Omega$ )	$I_D$ (A)
600	0.9 @ $V_{GS} = 10V$	10

### Mechanical Data

- Case: TO-220AB, ITO-220AB Package

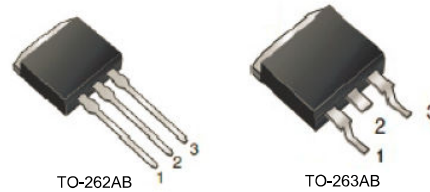
### Ordering Information

Part No.	Package	Packing
AT10N60S	TO-220AB	50pcs / Tube
AF10N60S	ITO-220AB	50pcs / Tube
AK10N60S	TO-262AB	50pcs / Tube
AG10N60S	TO-263AB	800pcs / 13" Reel

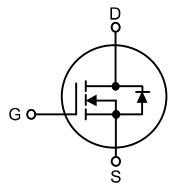


Pin Definition:

1. Gate
2. Drain
3. Source



### Block Diagram



### ABSOLUTE MAXIMUM RATINGS ( $T_C = 25^\circ C$ , unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{DSS}$	600	V
Gate-Source Voltage		$V_{GSS}$	$\pm 30$	V
Continuous Drain Current		$I_D$	10	A
Pulsed Drain Current (Note 2)		$I_{DM}$	38	A
Avalanche Energy	Single Pulsed (Note 3)	$E_{AS}$	700	mJ
Power Dissipation	TO-220AB/TO-262AB TO-263AB	$P_D$	156	W
	ITO-220AB		50	W
Junction Temperature		$T_J$	+150	$^\circ C$
Operating Temperature		$T_{OPR}$	-55 ~ +150	$^\circ C$
Storage Temperature		$T_{STG}$	-55 ~ +150	$^\circ C$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by  $T_J$

3.  $L = 30mH$ ,  $I_{AS} = 6.4A$ ,  $V_{DD} = 50V$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^\circ C$

### THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT
Junction to Ambient	TO-220AB/ITO-220AB TO-262AB/TO-263AB	$\theta_{JA}$	62.5	$^{\circ}\text{C}/\text{W}$
Junction to Case	TO-220AB	$\theta_{JC}$	0.85	$^{\circ}\text{C}/\text{W}$
	ITO-220AB		2.6	

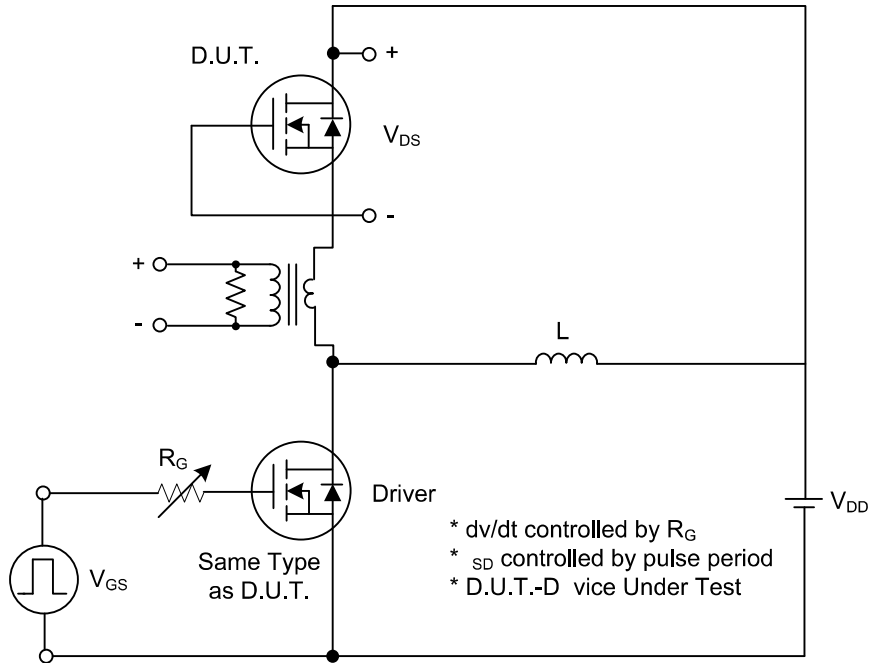
### ELECTRICAL CHARACTERISTICS ( $T_C=25^{\circ}\text{C}$ , unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OFF CHARACTERISTICS</b>							
Drain-Source Breakdown Voltage		$BV_{DSS}$	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	600			V
Drain-Source Leakage Current		$I_{DSS}$	$V_{DS}=600\text{V}, V_{GS}=0\text{V}$			1	$\mu\text{A}$
Gate- Source Leakage Current	Forward	$I_{GSS}$	$V_G=30\text{V}, V_{DS}=0\text{V}$			100	nA
	Reverse		$V_{GS}=-30\text{V}, V_{DS}=0\text{V}$			-100	nA
<b>ON CHARACTERISTICS</b>							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.0		4.0	V
Static Drain-Source On-State Resistance		$R_{DS(ON)}$	$V_{GS}=10\text{V}, I_D=5\text{A}$		0.76	0.9	$\Omega$
<b>DYNAMIC CHARACTERISTICS</b>							
Input Capacitance		$C_{ISS}$	$V_{DS}=25\text{V}, V_{GS}=0\text{V}, f=1.0\text{ MHz}$		1570		pF
Output Capacitance		$C_{OSS}$			166		pF
Reverse Transfer Capacitance		$C_{RSS}$			18		pF
<b>SWITCHING CHARACTERISTICS</b>							
Turn-On Delay Time		$t_{D(ON)}$	$V_{DD}=300\text{V}, I_D=10\text{A},$ $R_G=25\Omega$ (Note 1, 2)		23		ns
Turn-On Rise Time		$t_R$			69		ns
Turn-Off Delay Time		$t_{D(OFF)}$			144		ns
Turn-Off Fall Time		$t_F$			77		ns
Total Gate Charge		$Q_G$	$V_{DS}=480\text{V}, I_D=10\text{A},$ $V_{GS}=10\text{V}$ (Note 1, 2)		44		nC
Gate-Source Charge		$Q_{GS}$			6.7		nC
Gate-Drain Charge		$Q_{GD}$			18.5		nC
<b>DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS</b>							
Drain-Source Diode Forward Voltage		$V_{SD}$	$V_{GS}=0\text{V}, I_S=10\text{A}$			1.4	V
Maximum Continuous Drain-Source Diode Forward Current		$I_S$				10	A
Maximum Pulsed Drain-Source Diode Forward Current		$I_{SM}$				40	A
Reverse Recovery Time		$t_{rr}$	$V_{GS}=0\text{V}, I_S=10\text{A},$		450		ns
Reverse Recovery Charge		$Q_{RR}$	$di/dt=100\text{ A}/\mu\text{s}$ (Note 1)		4.2		$\mu\text{C}$

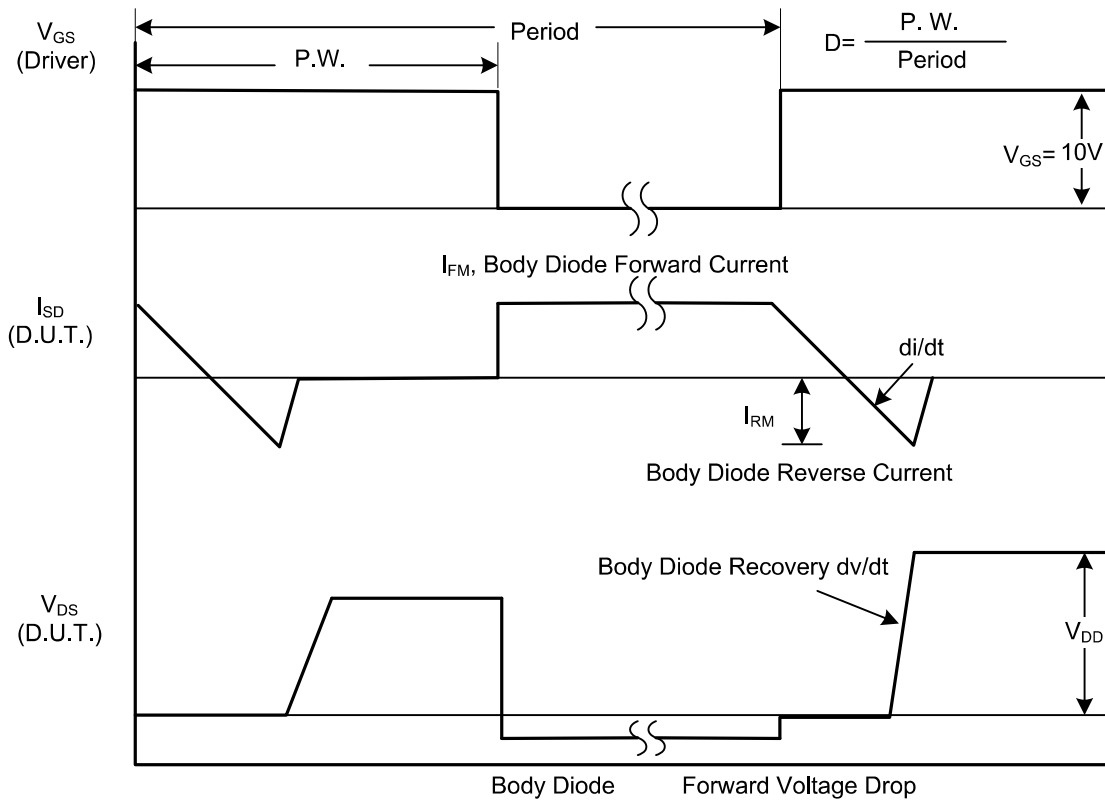
Notes: 1. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$ .

2. Essentially independent of operating temperature.

## TEST CIRCUITS AND WAVEFORMS

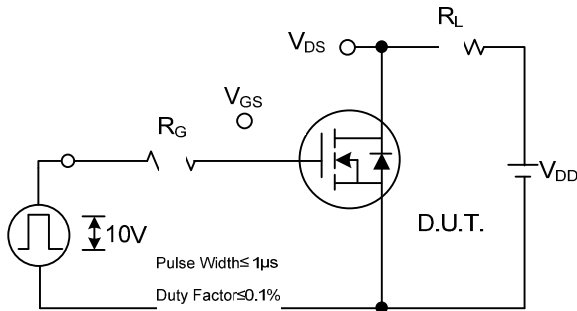


**Peak Diode Recovery dv/dt Test Circuit**

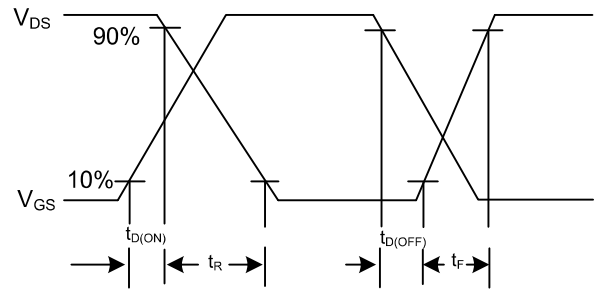


**Peak Diode Recovery dv/dt Waveforms**

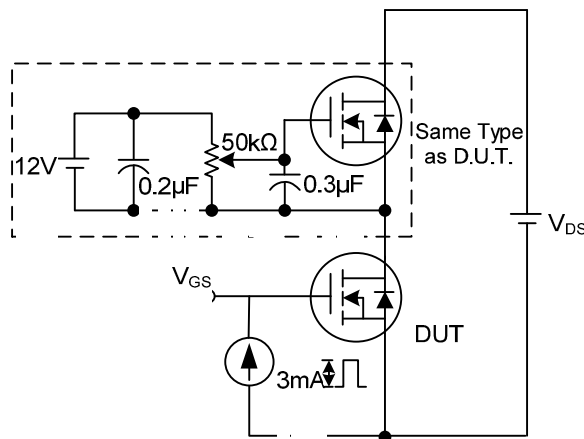
### TEST CIRCUITS AND WAVEFORMS(Cont.)



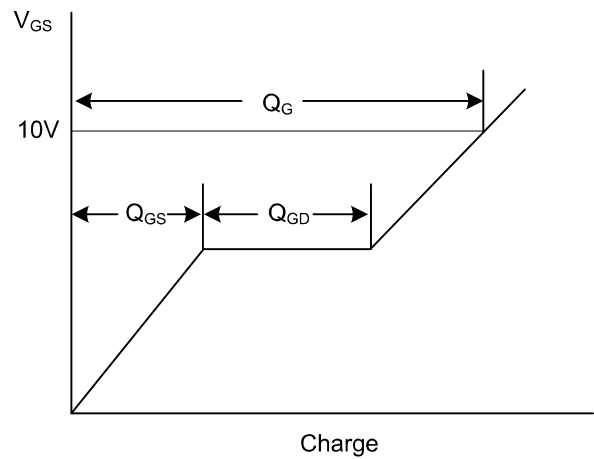
**Switching Test Circuit**



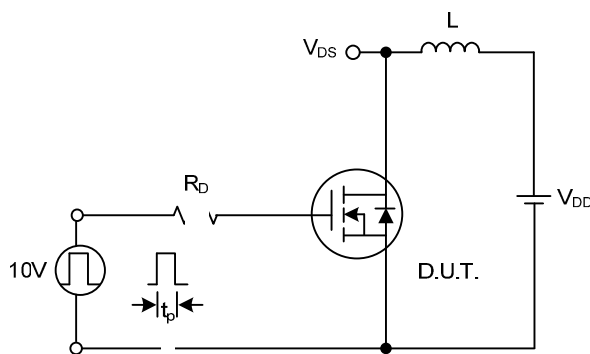
**Switching Waveforms**



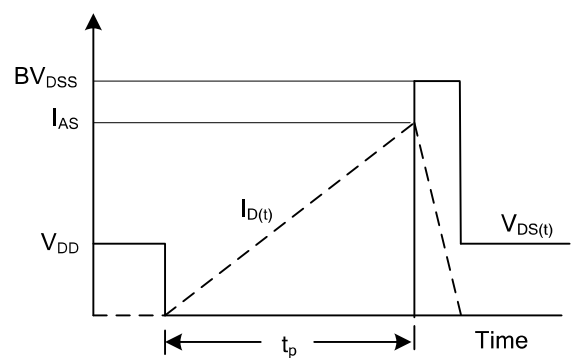
**Gate Charge Test Circuit**



**Gate Charge Waveform**



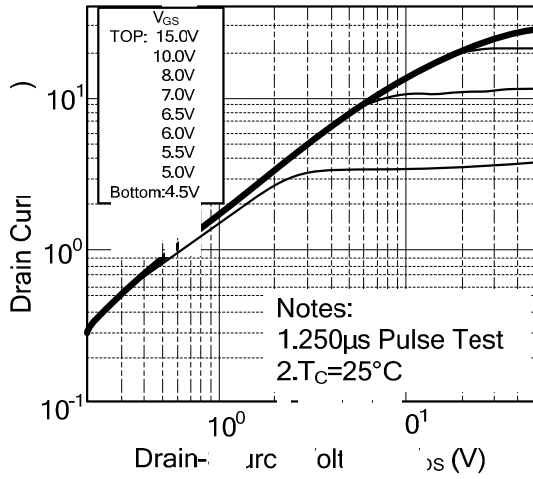
**Unclamped Inductive Switching Test Circuit**



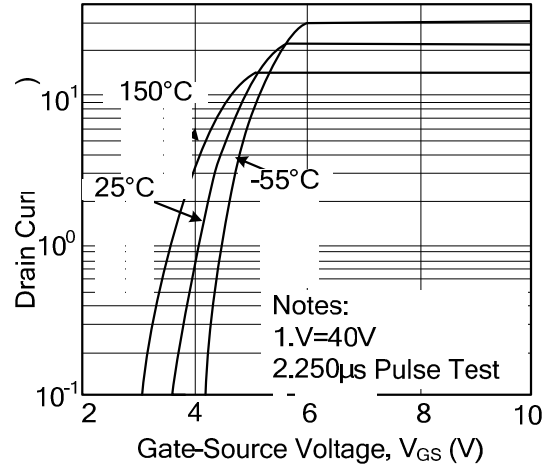
**Unclamped Inductive Switching Waveforms**

### TYPICAL CHARACTERISTICS

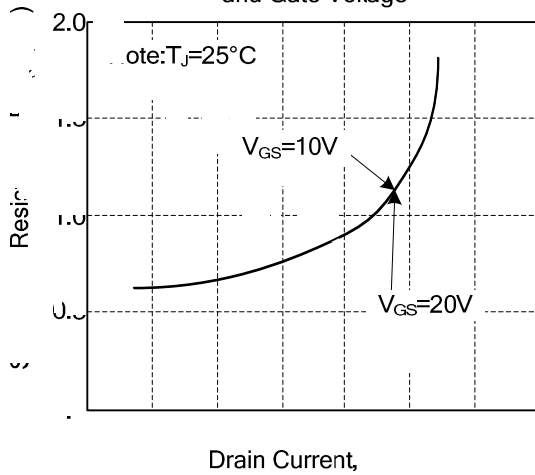
On-Region Characteristics



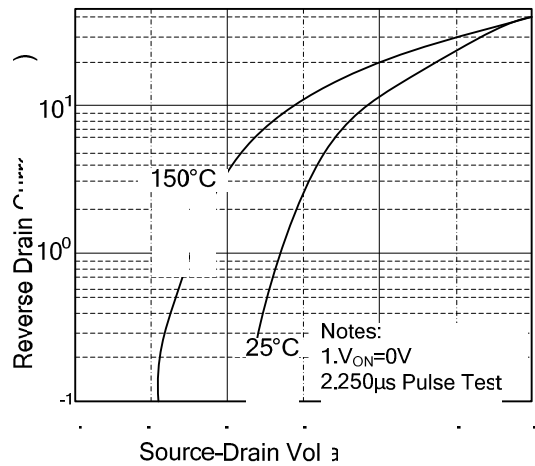
Transfer Characteristics



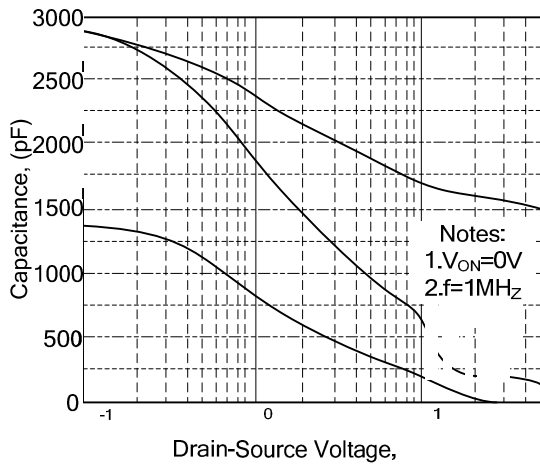
On-Resistance Variation vs. Drain Current and Gate Voltage



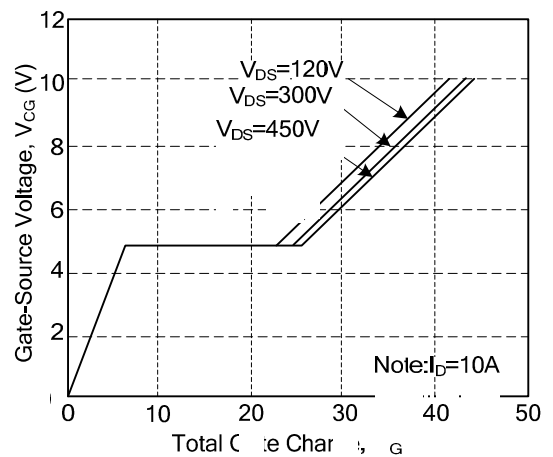
Body Diode Forward Voltage Variation with Source Current and Temperature



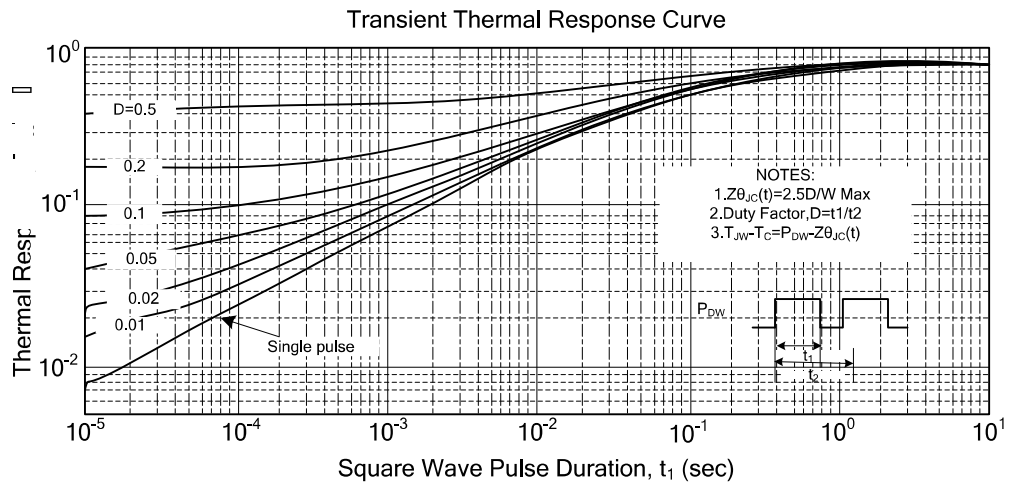
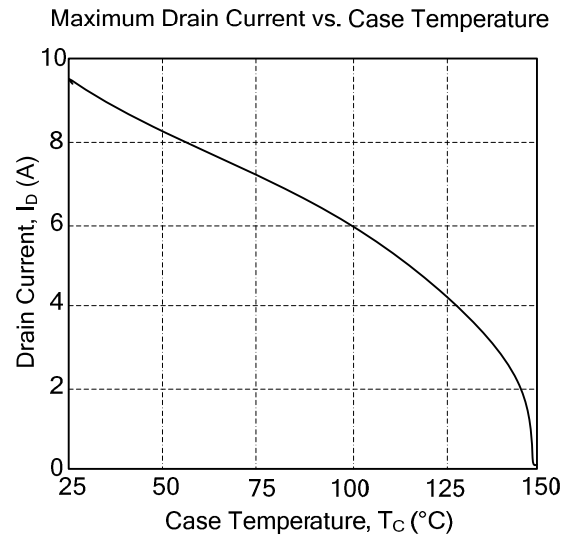
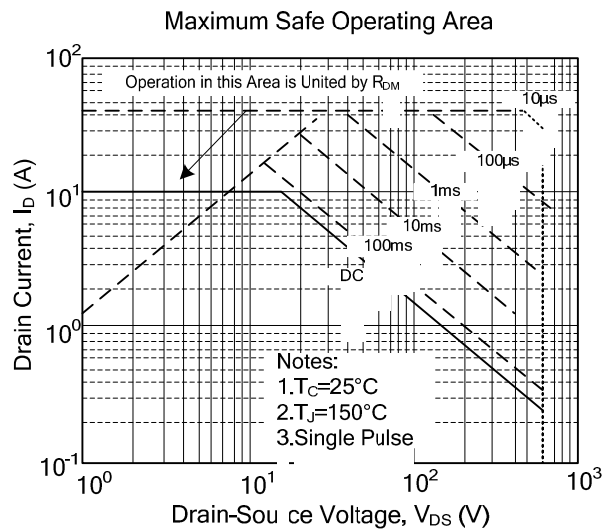
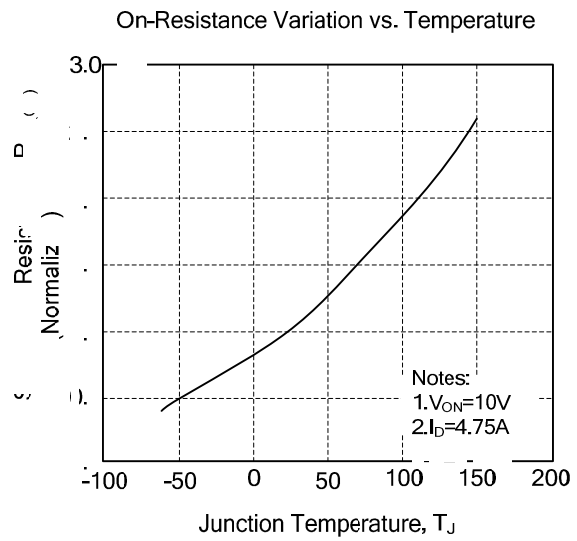
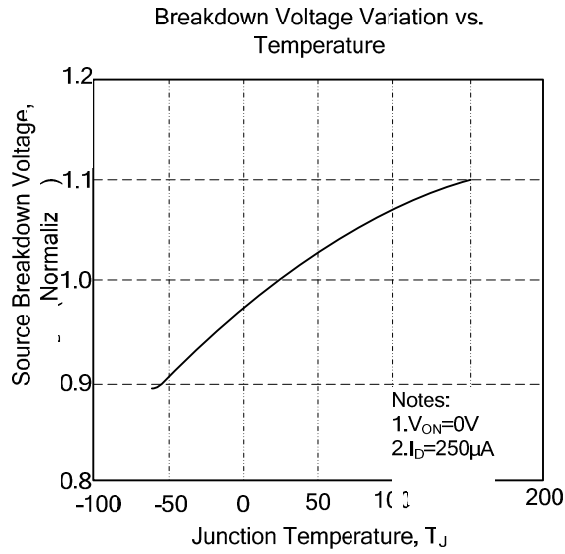
Capacitance Characteristics



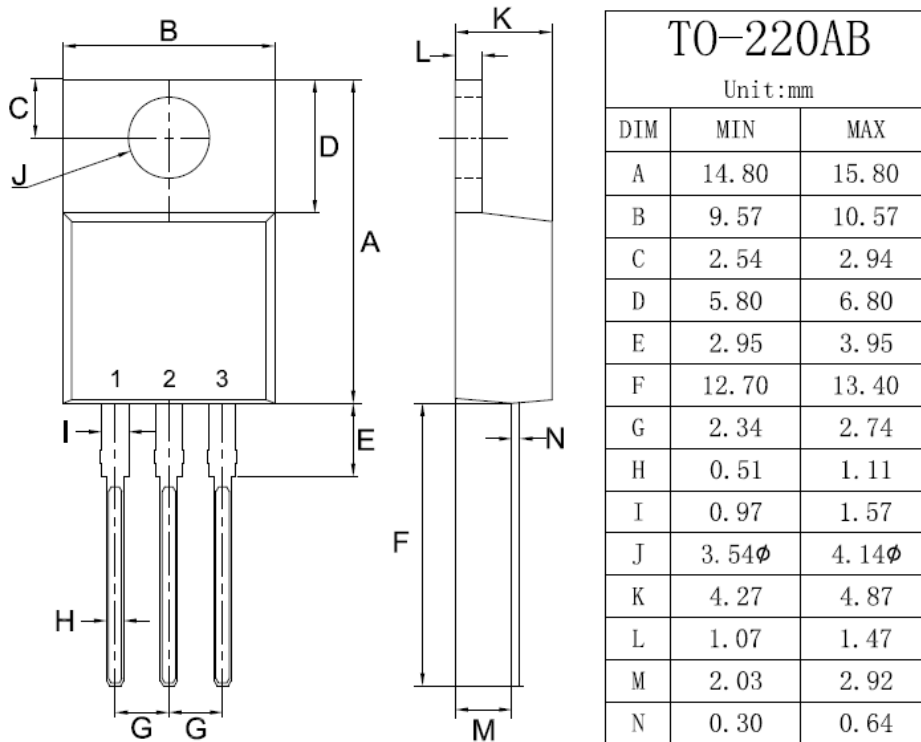
Gate Charge Characteristics



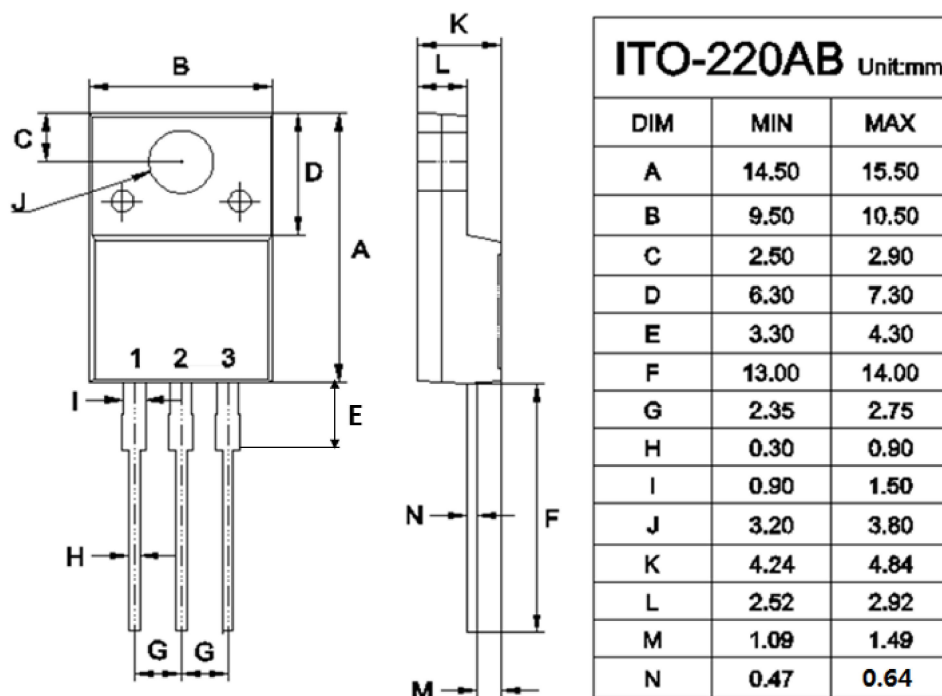
### TYPICAL CHARACTERISTICS



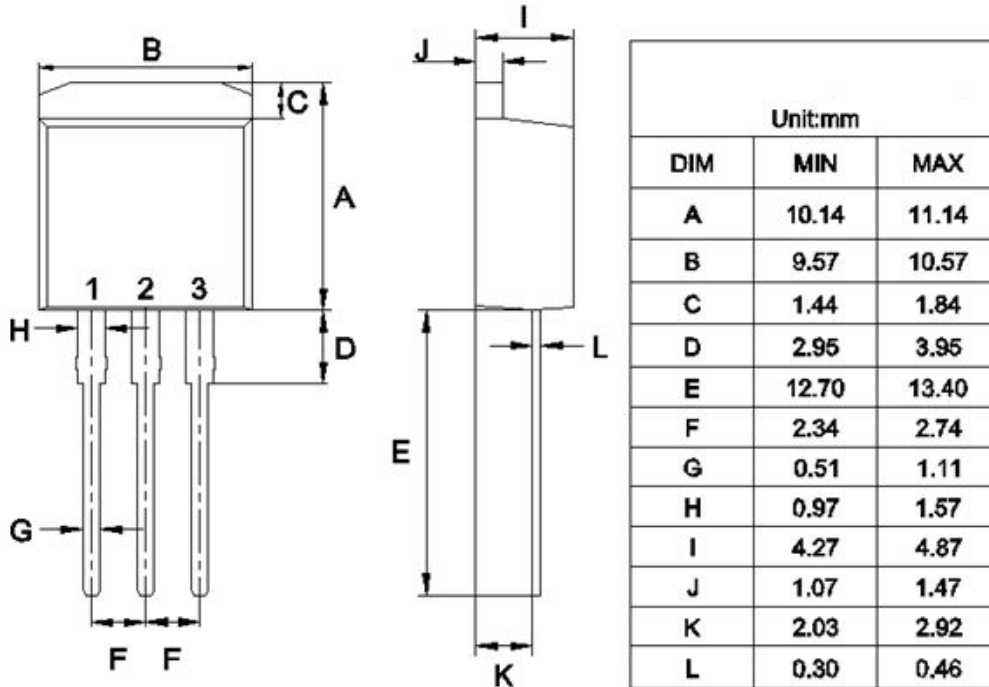
### TO-220AB Mechanical Drawing



### ITO-220AB Mechanical Drawing



### TO-262AB Mechanical Drawing



### TO-263AB Mechanical Drawing

